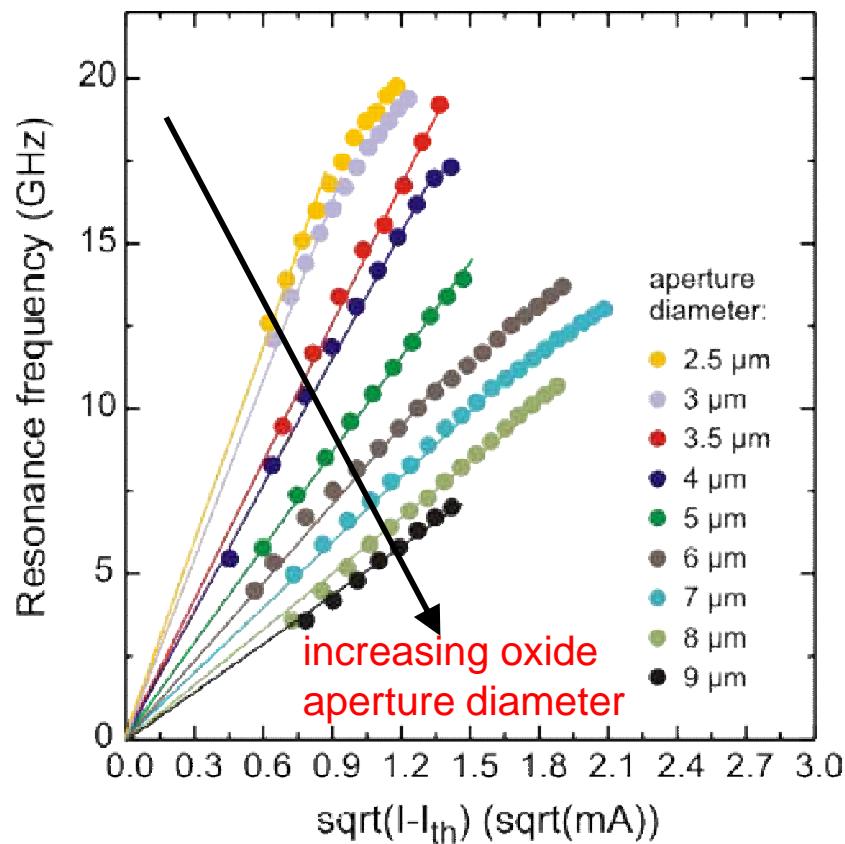
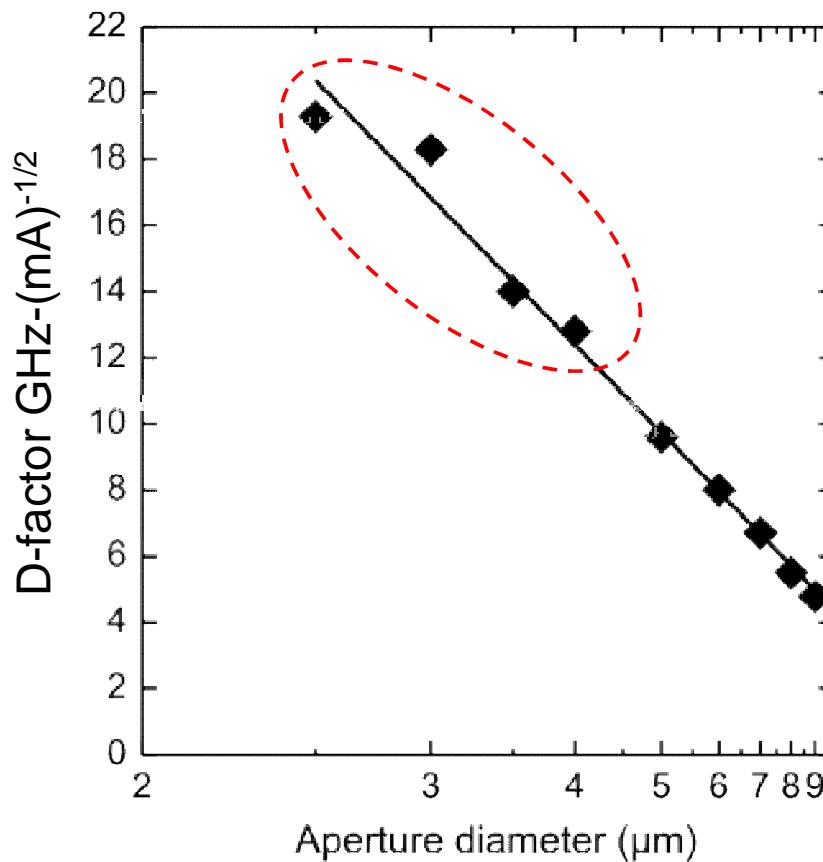


The D-factor versus the oxide aperture diameter



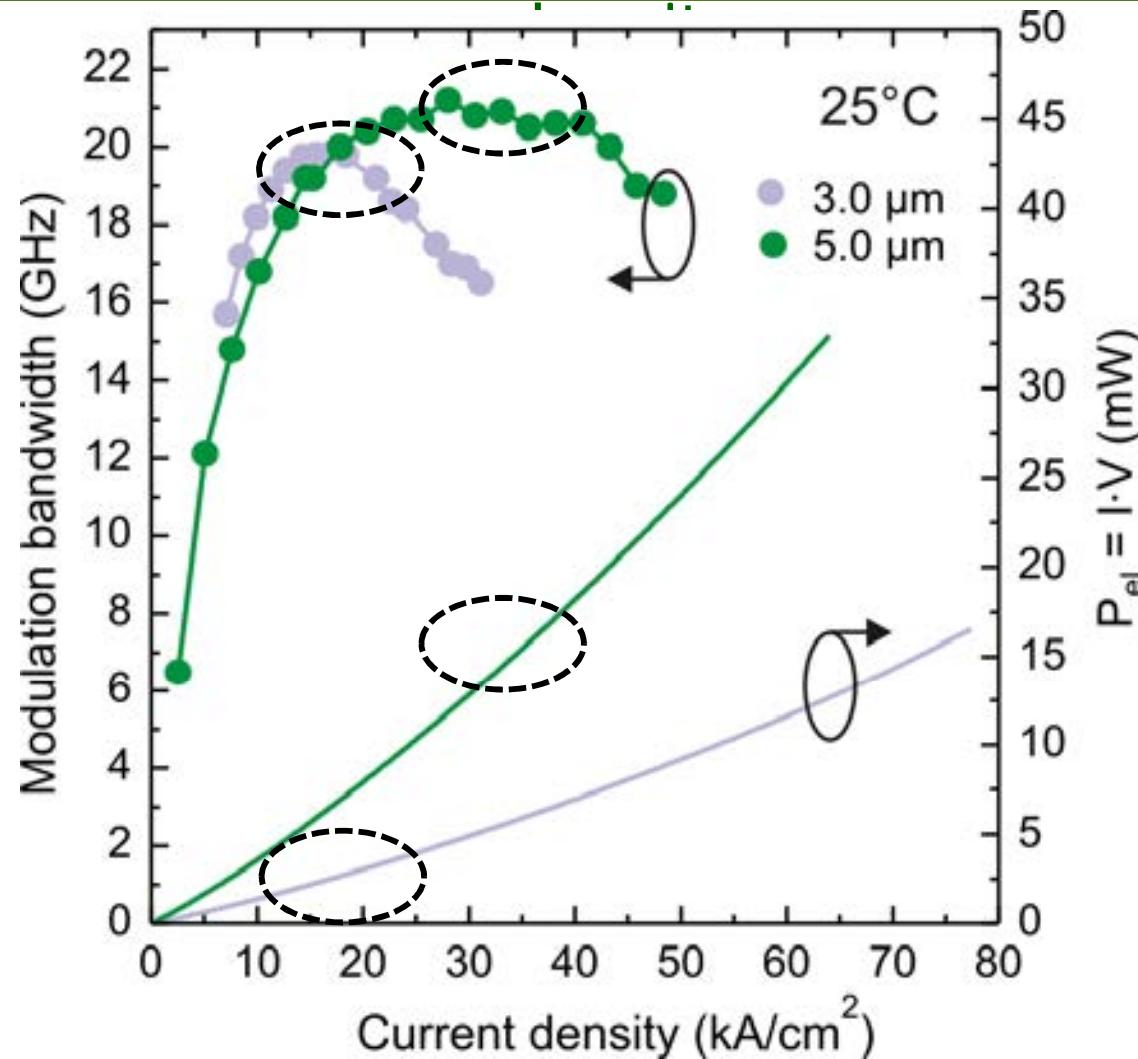
$$f_r = D \sqrt{I - I_{th}}$$

$$f_{3dB\max} = \sqrt{1 + \sqrt{2}} f_r \approx 1.55 f_r$$



$$D \propto \frac{1}{d_{aperture}}$$

P. Moser, ..., D. Bimberg, IEEE JSTQE, 19 (4), 2013.



5 μm aperture dia.

$$J = 33 \text{ kA}/\text{cm}^2$$

$$f_{3\text{dB}} = 21 \text{ GHz}$$

$$P_{el} = 15 \text{ mW}$$

3 μm aperture dia.

$$J = 17 \text{ kA}/\text{cm}^2$$

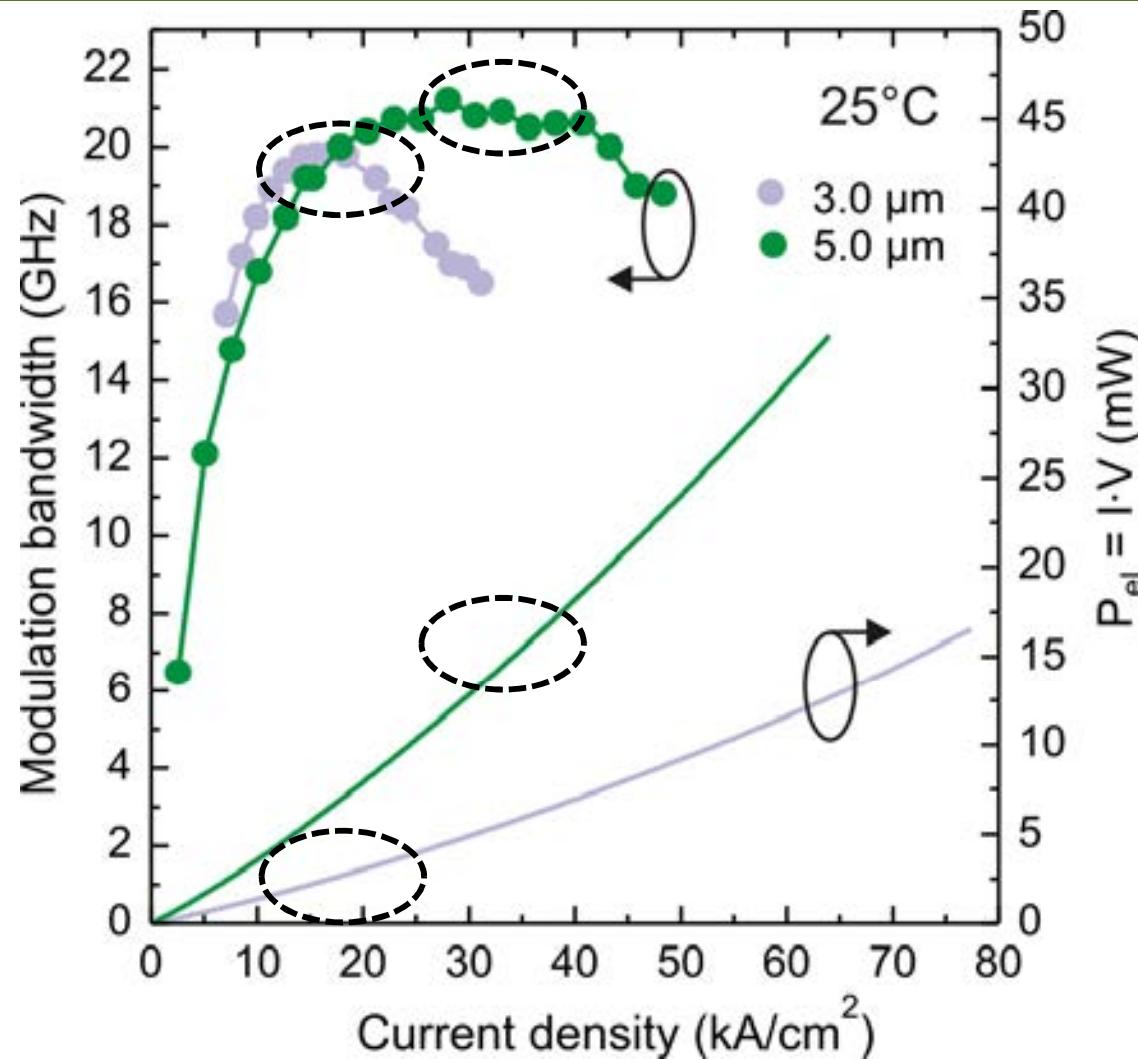
$$f_{3\text{dB}} = 20 \text{ GHz}$$

$$P_{el} = 8 \text{ mW}$$

- smaller aperture VCSELs → have a slightly smaller maximum $f_{3\text{dB}}$
 → at a much smaller electrical power
 → at a smaller current density

P. Moser, ..., D. Bimberg, Invited Talk Photonics West, San Francisco, CA, USA, SPIE 9001-2 (2014).

Modulation bandwidth and current density



5 μm aperture dia.

$J = 33 \text{ kA}/\text{cm}^2$
 $f_{3\text{dB}} = 21 \text{ GHz}$
 $P_{el} = 15 \text{ mW}$

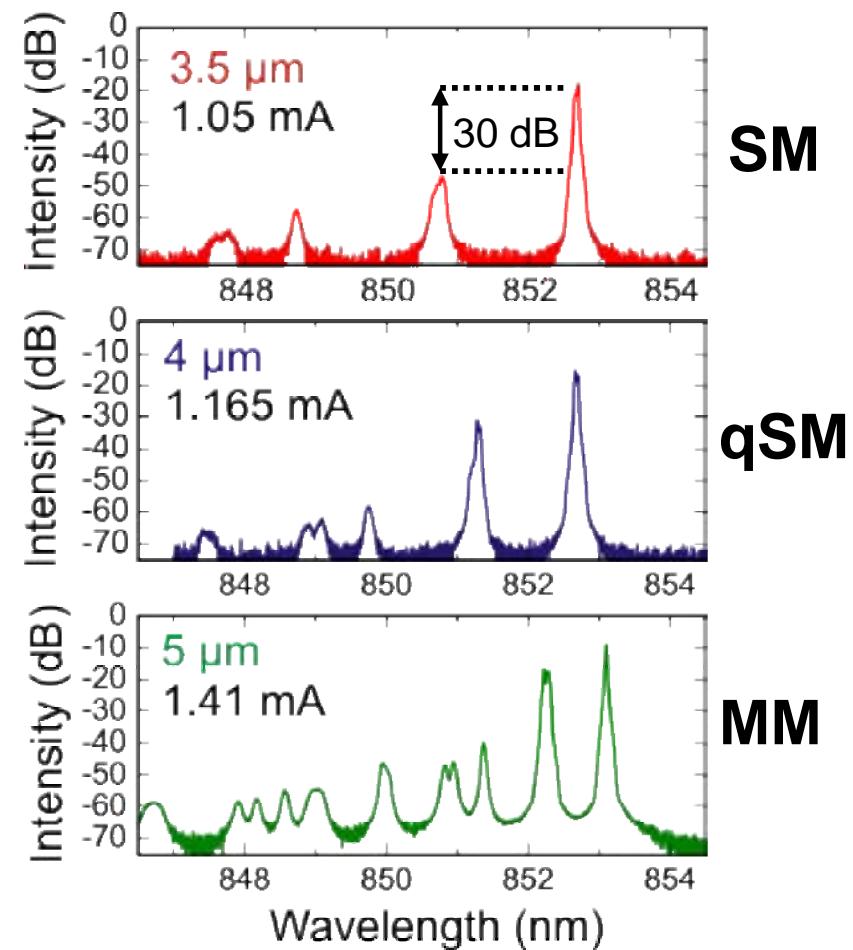
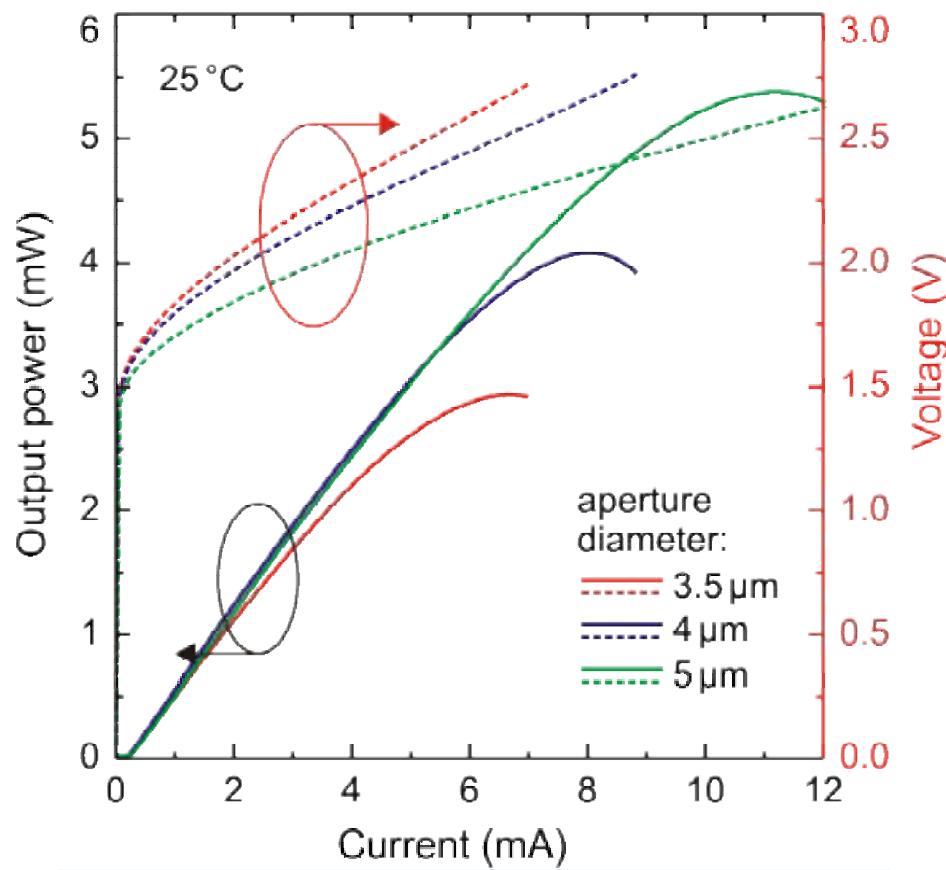
3 μm aperture dia.

$J = 17 \text{ kA}/\text{cm}^2$
 $f_{3\text{dB}} = 20 \text{ GHz}$
 $P_{el} = 8 \text{ mW}$

$$\frac{f_{3\text{dB}}}{P_{el}} \text{ (GHz/mW)}$$

5 μm	3 μm
1.4	2.5

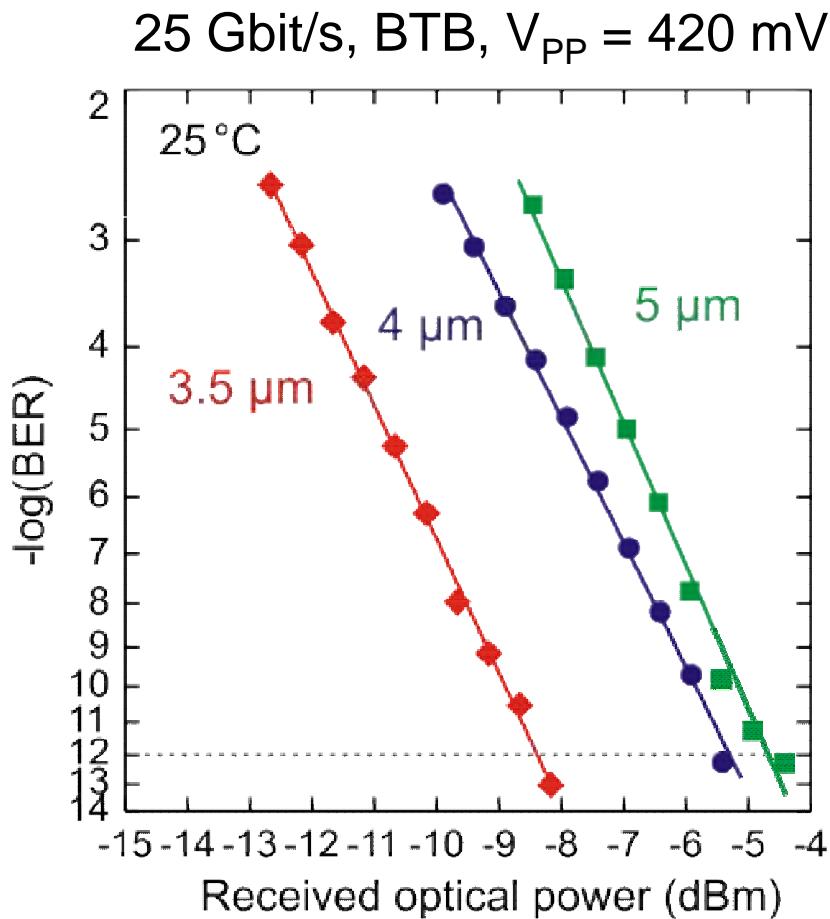
79% more
bandwidth per mW!



	P_{th}	R_d
3.5 μm:	240 μW	220 Ω
4 μm:	310 μW	190 Ω
5 μm:	380 μW	140 Ω

	$\Delta\lambda_{RMS}$
3.5 μm:	0.08 nm
4 μm:	0.22 nm
5 μm:	0.42 nm

P. Moser, ..., D. Bimberg, Electronics Letters, vol.48, no.20, pp. 1292-1293, 2012.



3.5 μm:

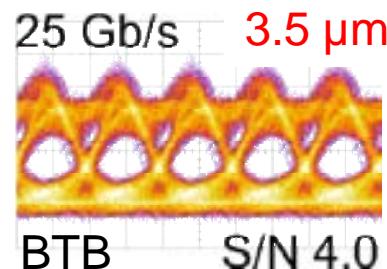
- $EDR = 77$ fJ/bit
- $HBR = 56$ fJ/bit

4 μm:

- $EDR = 85$ fJ/bit
- $HBR = 58$ fJ/bit

5 μm:

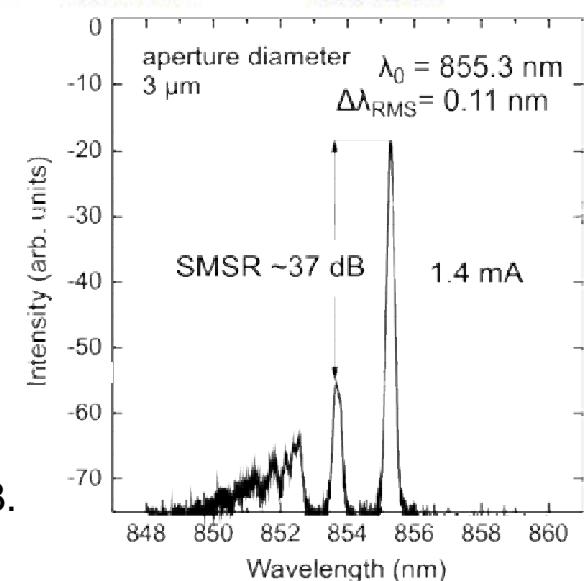
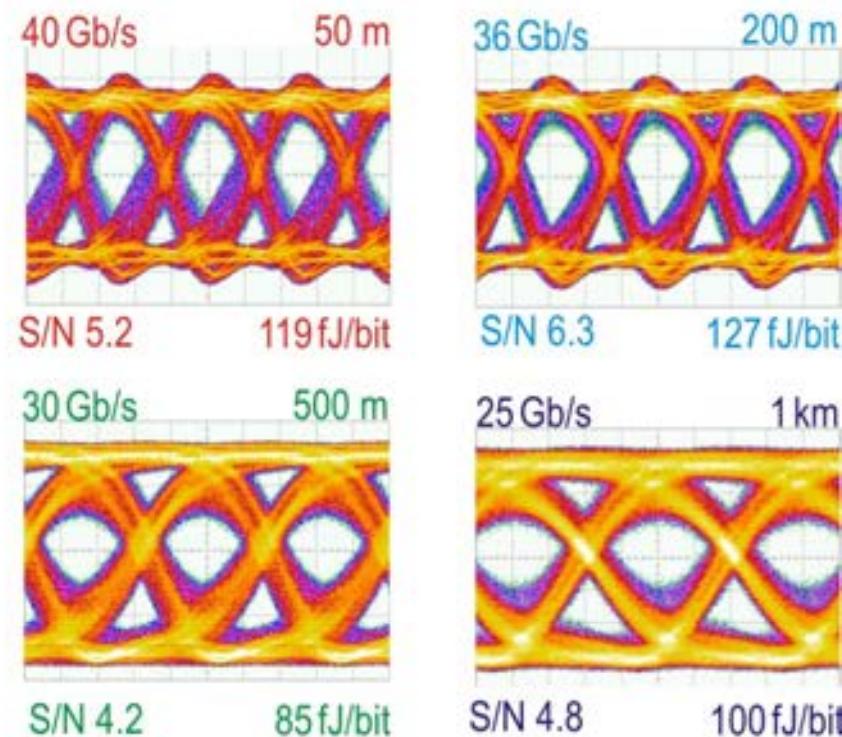
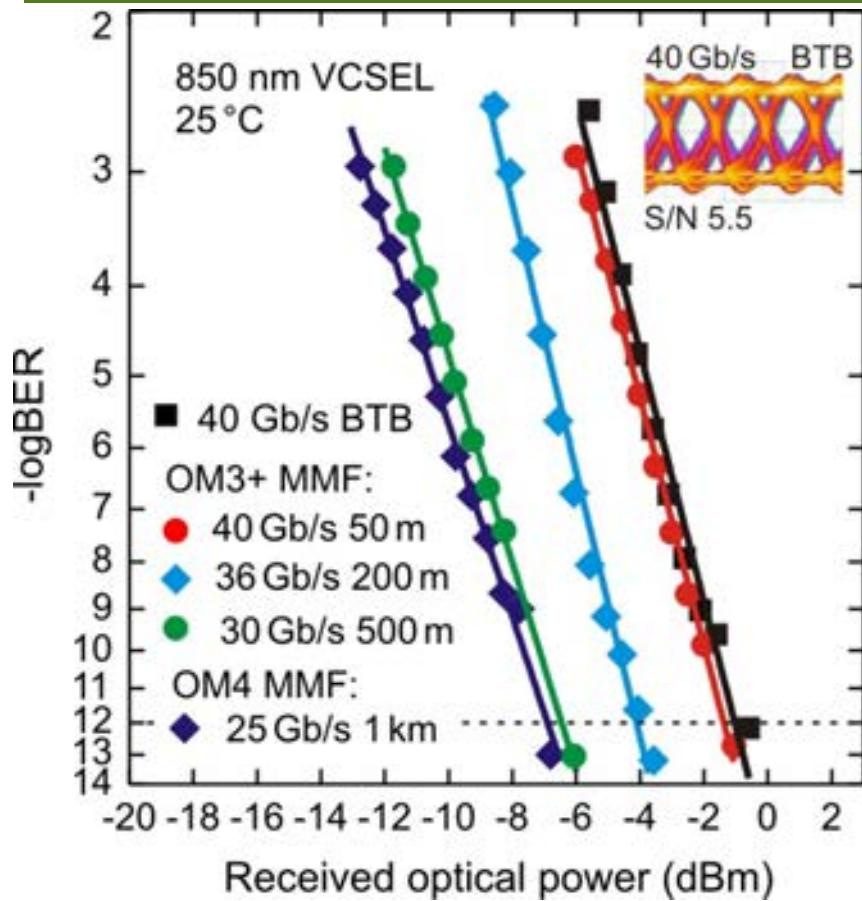
- $EDR = 99$ fJ/bit
- $HBR = 67$ fJ/bit



Record energy-efficient
directly modulated VCSELs

P. Moser, ..., D. Bimberg, Electronics Letters, 48(20), 2012.

High bit rates, toward long MMF distances



25 Gbit/s [1]
1 km MMF
100 fJ/bit

30 Gbit/s [1]
500 m MMF
85 fJ/bit

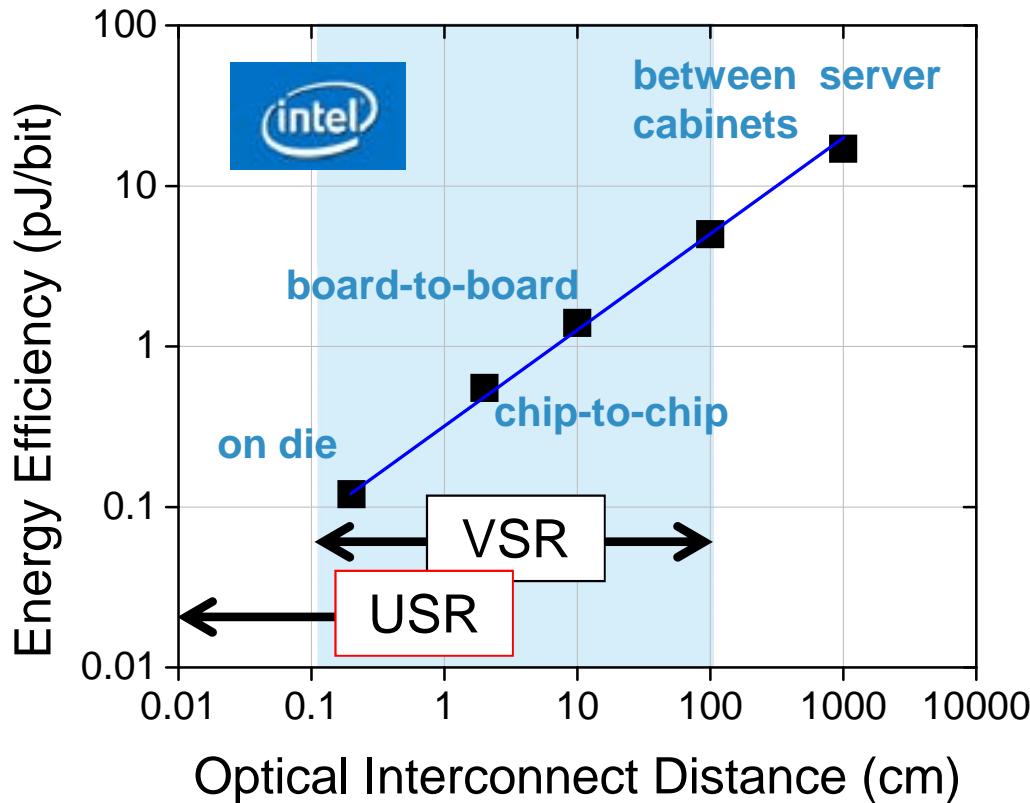
40 Gbit/s [2]
BTB
108 fJ/bit

[1] P. Moser, ..., D. Bimberg, IEEE Photonics Technology Letters, 25(6), 2013.

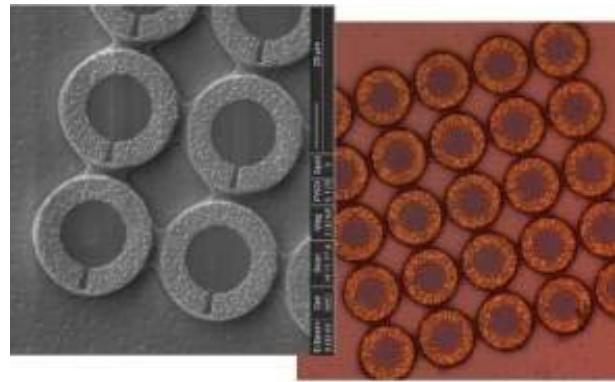
[2] P. Wolf, ..., D. Bimberg, Electronics Letters, 49(10), 2013.

very-short-reach (VSR) optical interconnects: < 2 m

ultra-short-reach (USR) optical interconnects: < 20 mm



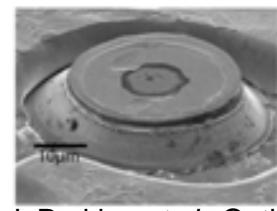
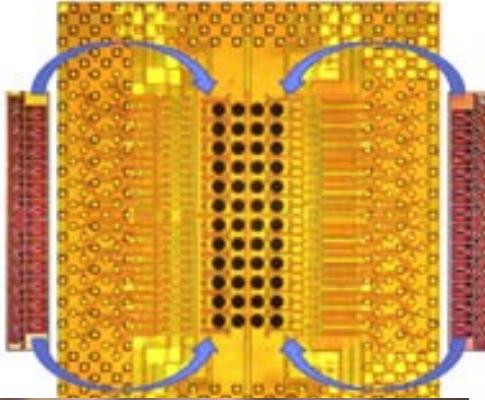
after: S. Borkar, Proc. IEEE Optical Interconnects conference, Santa Fe, NM USA (08 May 2013)



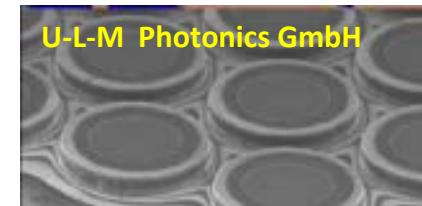
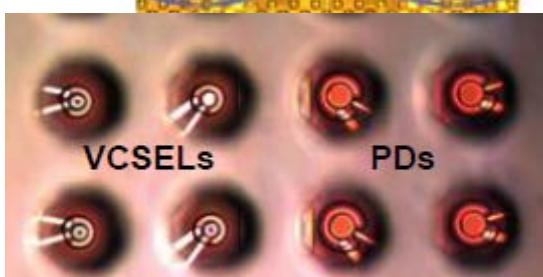
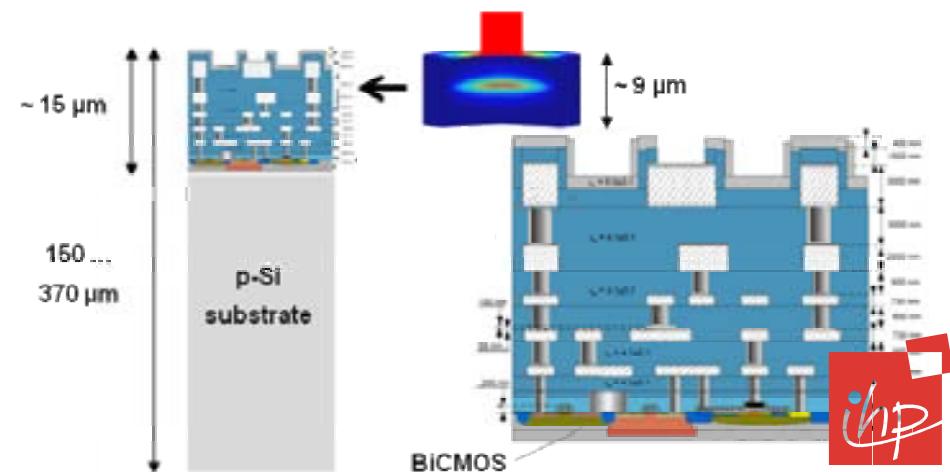
J. A. Lott *et al.*, Proc. IEEE Summer Topical (July 2002).

VCSELs on
CMOS
MEMS
silicon
flexible plastic
fabrics
and more

24 TX + 24 RX @ 20 Gbit/s = 0.96 Tb/s

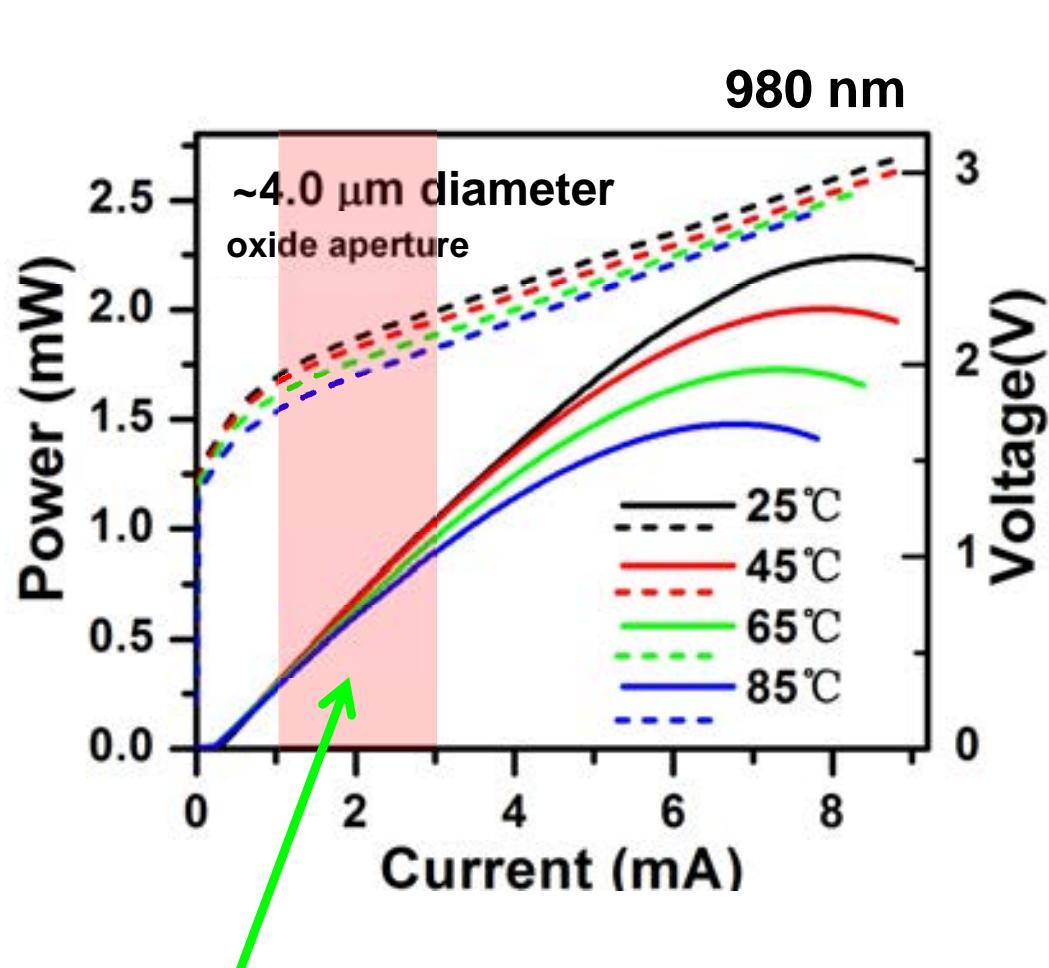


J. Perkins *et al.*, Optics Express, 16(8) (Aug 2008).

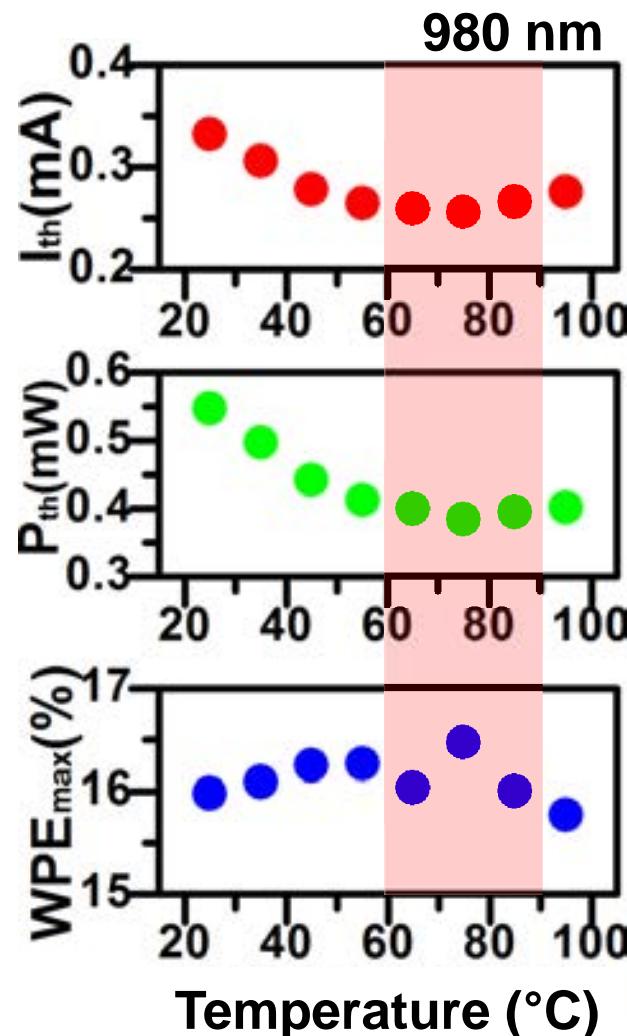


N. Li *et al.*, (IBM) OFC 2010, paper OTuP2.

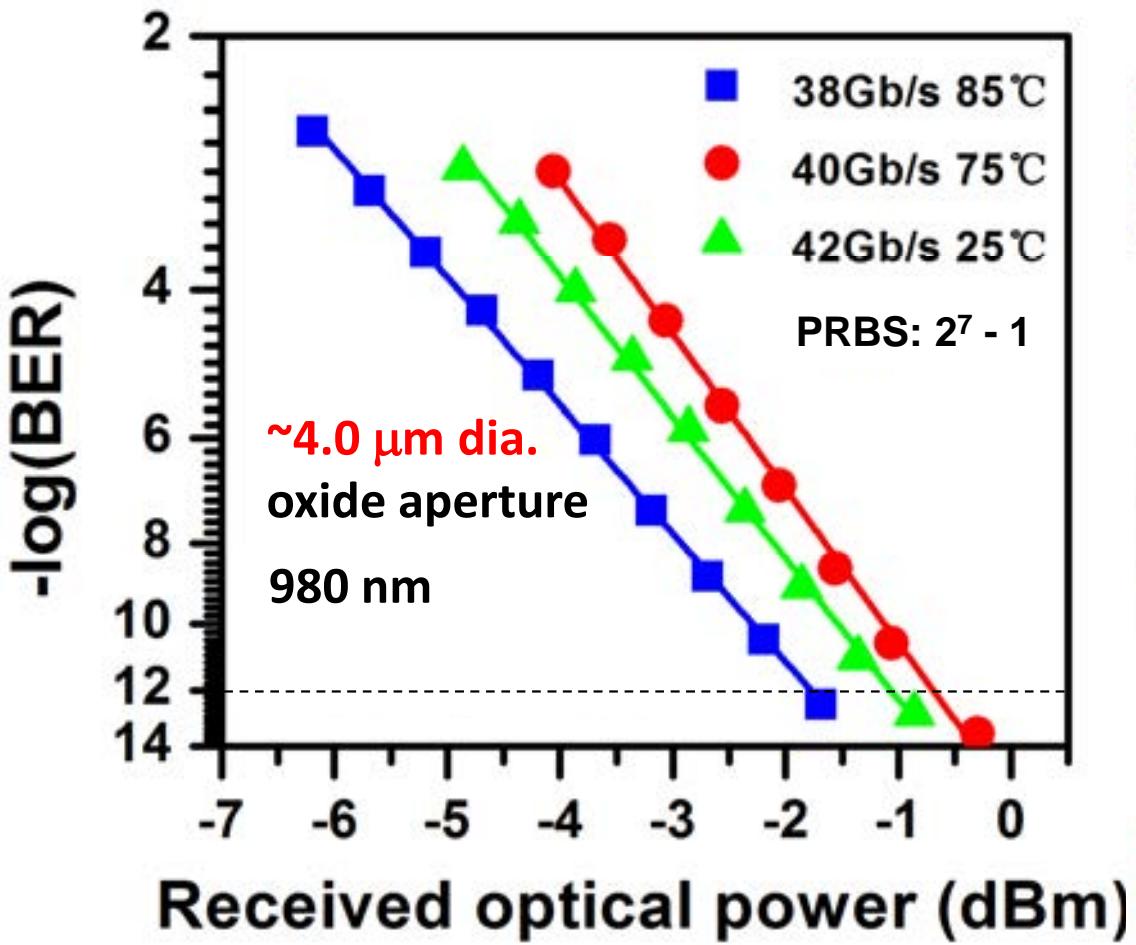




the L-I characteristics are ~constant with temperature from 25 to 85°C near threshold

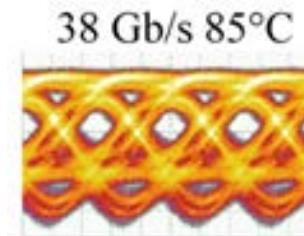


non-return-to-zero (NRZ) modulation



bit error ratio = BER
define “error-free” as a BER < 1E-12

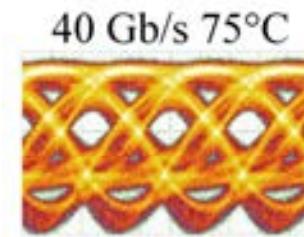
best optical eyes



5.4 mA; 2.45 V; 1.39 mW

38 Gbit/s at 85°C:

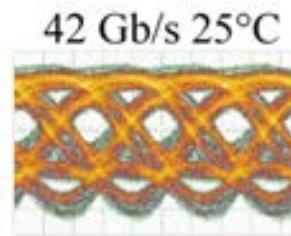
- $EDR = 348 \text{ fJ/bit}$
- $HBR = 312 \text{ fJ/bit}$
- $J = 43.0 \text{ kA/cm}^2$



5.0 mA; 2.40 V; 1.40 mW

40 Gbit/s at 75°C:

- $EDR = 300 \text{ fJ/bit}$
- $HBR = 265 \text{ fJ/bit}$
- $J = 39.8 \text{ kA/cm}^2$

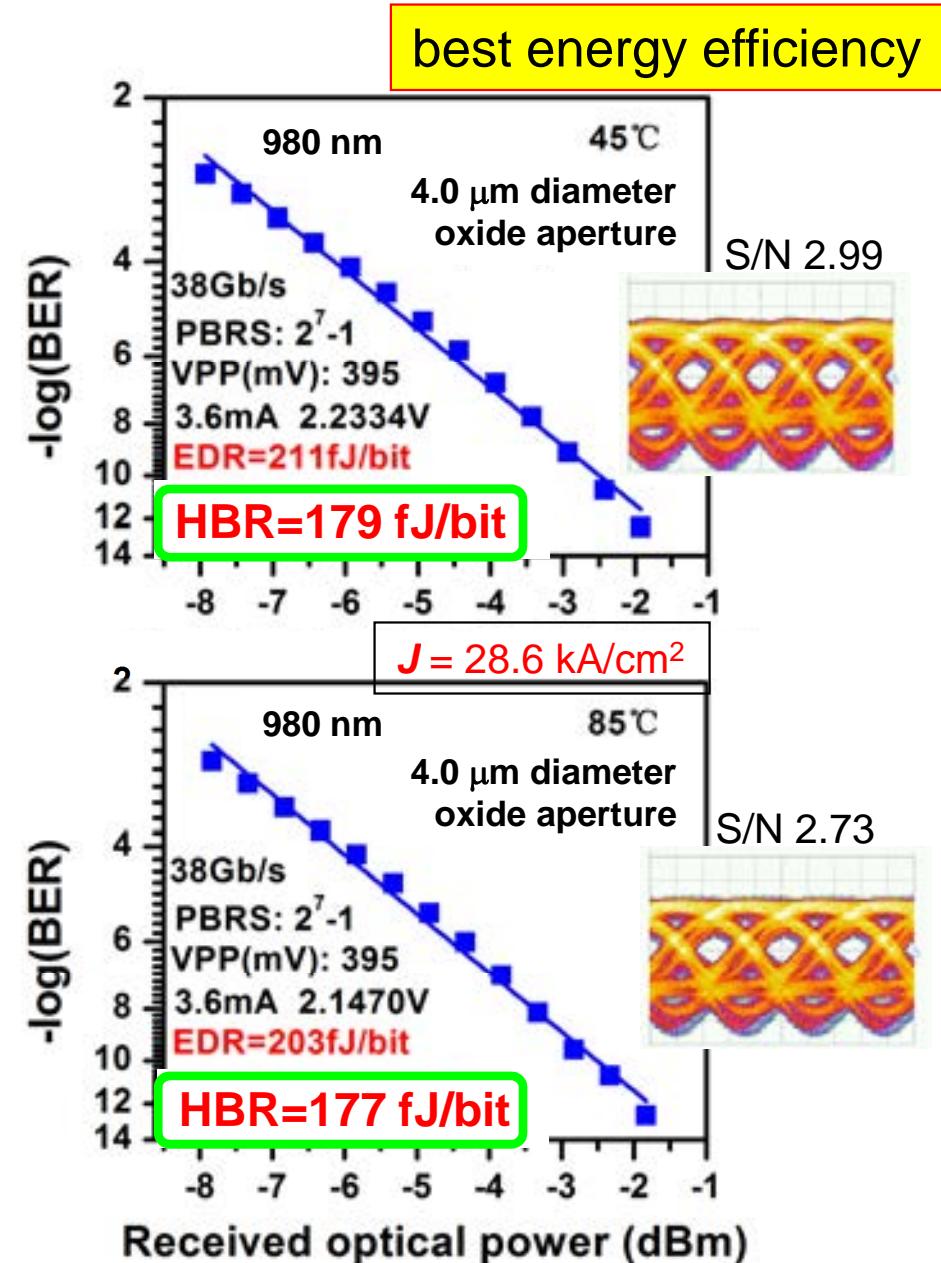
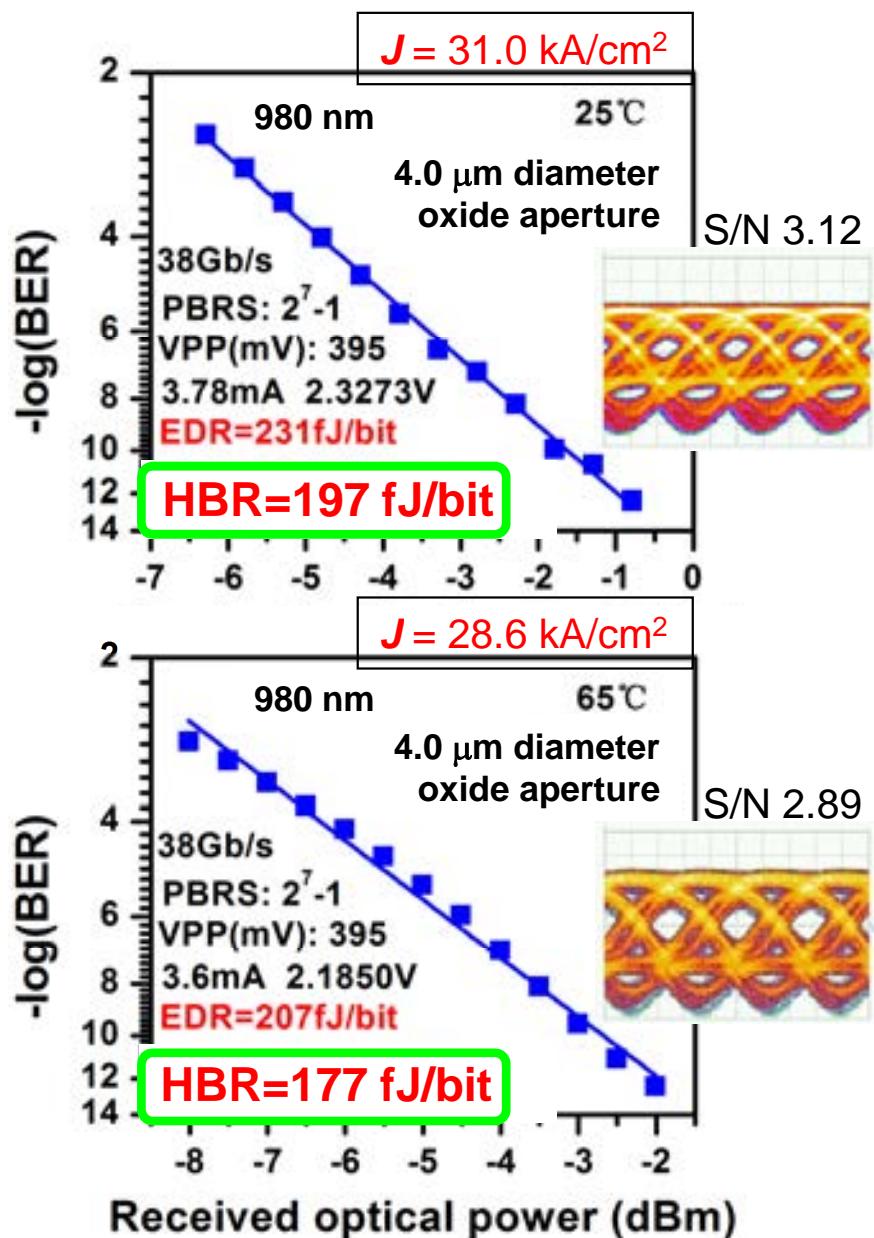


5.5 mA; 2.59 V; 1.81 mW

42 Gbit/s at 25°C:

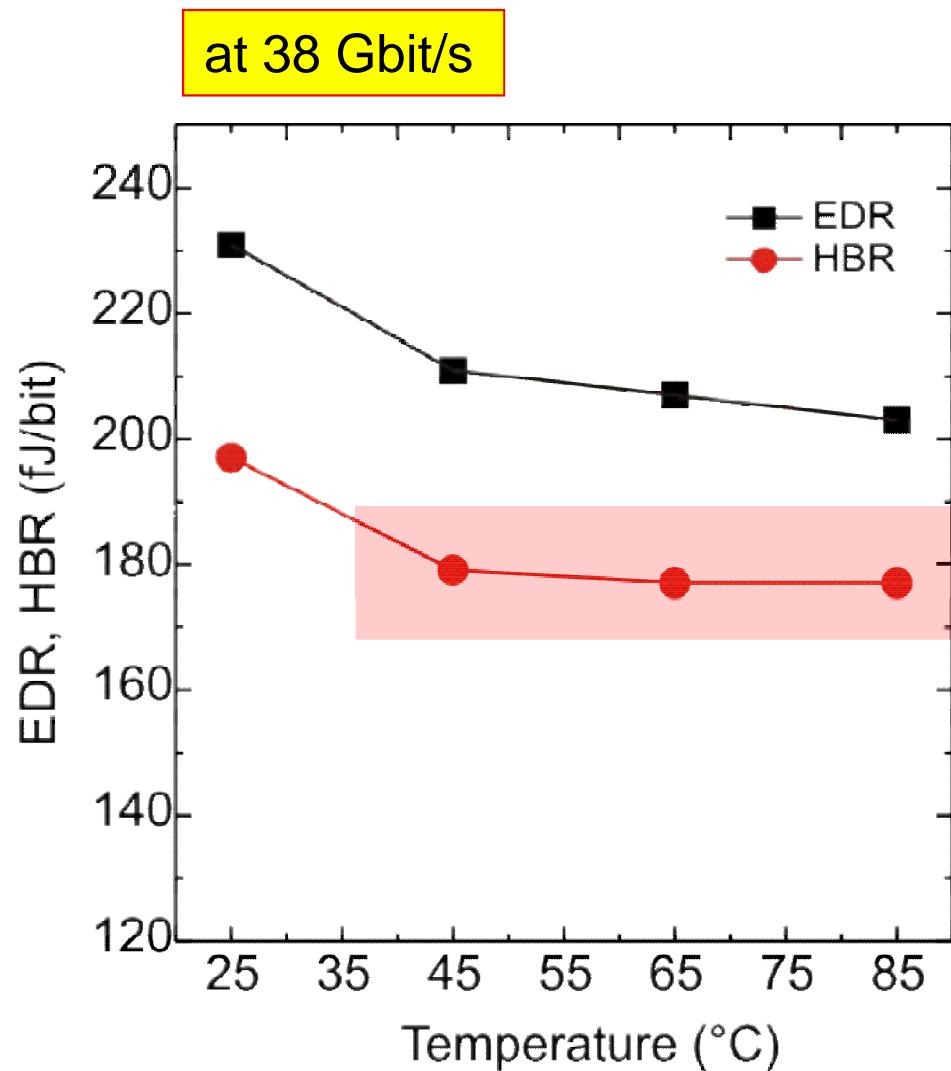
- $EDR = 339 \text{ fJ/bit}$
- $HBR = 296 \text{ fJ/bit}$
- $J = 43.8 \text{ kA/cm}^2$

38 Gbit/s error-free BER tests 25 to 85°C



H. Li, P. Moser, ..., D. Bimberg, Photonics West, San Francisco, CA, USA, SPIE 9001-10 (2014).

Energy efficiency vs. temperature



Highly temperature stable
energy dissipation per bit

H. Li, P. Moser, ..., D. Bimberg, Photonics West, San Francisco, CA, USA, SPIE 9001-10 (2014).